TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC7SET00F, TC7SET00FU

2-INPUT NAND GATE

The TC7SET00 is an advanced high speed CMOS 2-INPUT NAND GATE fabricated with silicon gate CMOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The input threshold levels are compatible with TTL output voltage. This device can be used for level converter for interfacing 3V to 5V system.

An input protection circuit ensures that 0V to 7V can be applied to the input pins without regard to the supply voltage.

FEATURES

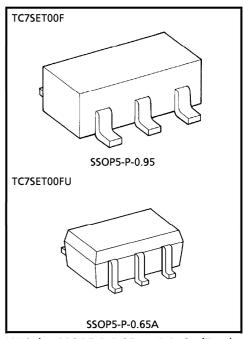
•	High	Speed		$t_{pd} = 5.0 \text{ns} (Typ.)$
				at \/aa = 5\/

• Low Power Dissipation
$$I_{CC} = 2\mu A$$
 (Max.) at $Ta = 25^{\circ}C$

• Compatible with TTL outputs
$$\cdots V_{IL} = 0.8V$$
 (Max.) $V_{IH} = 2.0V$ (Min.)

• Power Down Protection is provided on all inputs.

Balanced Propagation Delays ······ t_{pLH}=t_{pHL}

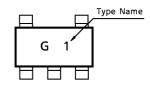


Weight SSOP5-P-0.95 : 0.016g (Typ.) SSOP5-P-0.65A : 0.006g (Typ.)

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	V _C C	-0.5~7.0	V
DC Input Voltage	VIN	-0.5~7.0	V
DC Output Voltage	VOUT	-0.5~V _{CC} +0.5	٧
Input Diode Current	Ικ	– 20	mΑ
Output Diode Current	loк	± 20	mA
DC Output Current	IOUT	± 25	mA
DC V _{CC} / Ground Current	lcc	± 50	mA
Power Dissipation	PD	200	mW
Storage Temperature	T _{stg}	- 65∼150	°C
Lead Temperature (10 s)	TL	260	°C

MARKING



TRUTH TABLE

А	В	Υ
L	L	Н
L	Н	Н
Η	L	Н
Η	Η	L

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TOSHIBA TC7SET00F/FU

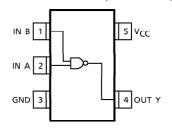
LOGIC DIAGRAM



RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	VCC	4.5~5.5	V
Input Voltage	VIN	0~5.5	V
Output Voltage	Vout	0~5.5	V
Operating Temperature	T _{opr}	- 40∼8 5	°C
Input Rise and Fall Time	dt/dv	0~20	ns / V

PIN ASSIGNMENT (TOP VIEW)



DC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	CANADOL	TEST CONDITION		Vcc	Ta = 25°C			Ta = -4	UNIT	
CHARACTERISTIC	STIVIBOL	TEST CO	(V)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT	
High-Level Input Voltage	VIH			4.5~ 5.5	2.0	_	_	2.0	_	٧
Low-Level Input Voltage	V _{IL}			4.5~ 5.5			0.8	_	0.8	٧
High-Level	Vall	V _{IN} = V _{IH}	$I_{OH} = -50\mu A$	4.5	4.4	4.5	_	4.4	_	٧
Output Voltage	VOH	or V _{IL}	$I_{OH} = -8mA$	4.5	3.94	_	_	3.80	_	'
Low-Level	Va.	V V	$I_{OL} = 50 \mu A$	4.5		0.0	0.10	_	0.10	٧
Output Voltage	VOL	$V_{IN} = V_{IH}$	I _{OL} = 8mA	4.5	_	_	0.36	_	0.44	V
Input Leakage	l	Las Mar E EM an CNE		0~	0~		± 0.1		± 1.0	
Current	Current IN		$V_{IN} = 5.5V$ or GND		-	_	1 0.1		_ 1.0	μ A
Quiescent Supply	lcc	$V_{IN} = V_{CC}$ or	GND	5.5		_	2.0	_	20.0	μ A
Current	ICCT	PER INPUT OTHER INPU	:V _{IN} = 3.4V T:V _{CC} or GND	5.5		_	1.35	_	1.50	mA

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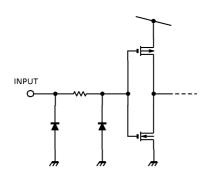
AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3n$

CHARACTERISTIC	SYMBOL	TEST CONDITION		N	Ta = 25°C		Ta = −40~85°C		UNIT	
CHARACTERISTIC	STIVIBUL		V _C C (V)	C _L (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	וואוט
Propagation Delay	t _{PLH}		5.0 ± 0.5	15	_	4.7	6.2	1.0	7.1	2
Time	t _{PHL}		3.0 ± 0.3		_	6.5	9.0	1.0	10.3	ns
Input Capacitance	CIN				_	4	10	_	10	
Power Dissipation		(Note 1)			17				pF	
Capacitance	CPD	(1)	iote i)		_	''	_	_	_	

(Note 1): CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation :

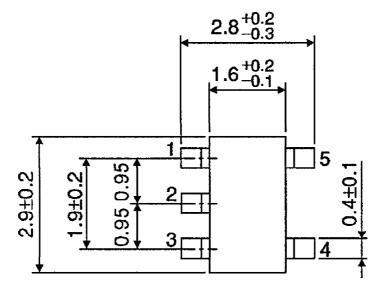
$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

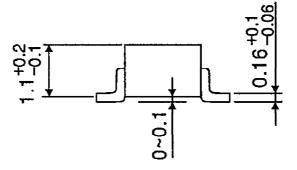
INPUT EQUIVALENT CIRCUIT



OUTLINE DRAWING SSOP5-P-0.95

Unit: mm

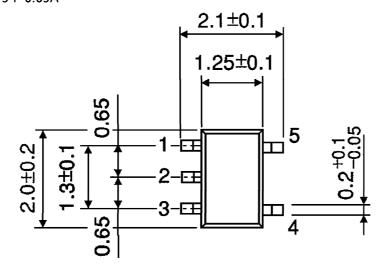


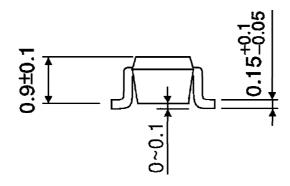


Weight: 0.016g (Typ.)

OUTLINE DRAWING SSOP5-P-0.65A

Unit: mm





Weight: 0.006g (Typ.)